# **MOSFET** – Power, N-Channel, SUPERFET III, Easy Drive

650 V, 12 A, 260 mΩ

#### **Description**

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate. Consequently, SUPERFET III MOSFET Easy drive series helps manage EMI issues and allows for easier design implementation.

#### **Features**

- 700 V @  $T_I = 150^{\circ}\text{C}$
- Typ.  $R_{DS(on)} = 222 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 24 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 248 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

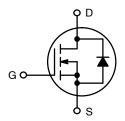
- Computing / Display Power Supplies
- Telecom / Server Power Supplies
- Industrial Power Supplies
- Lighting / Charger / Adapter



## ON Semiconductor®

#### www.onsemi.com

| V <sub>DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |  |
|------------------|-------------------------|--------------------|--|
| 650 V            | 260 mΩ @ 10 V           | 12 A               |  |



**POWER MOSFET** 



#### **MARKING DIAGRAM**



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Data Code (Year & Week)

&K = Lot

FCD260N65S3 = Specific Device Code

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

# ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, Unless otherwise specified)

| Symbol                            | Parame   | Value                               | Unit        |      |
|-----------------------------------|--|-------------------------------------|-------------|------|
| $V_{DSS}$                         | Drain to Source Voltage  |                                     | 650         | V    |
| $V_{GSS}$                         | Gate to Source Voltage   | DC                                  | ±30         | V    |
|                                   |  | AC (f > 1 Hz)                       | ±30         | V    |
| I <sub>D</sub>                    | Drain Current  | Continuous (T <sub>C</sub> = 25°C)  | 12          | Α    |
|                                   |  | Continuous (T <sub>C</sub> = 100°C) | 7.6         |      |
| I <sub>DM</sub>                   | Drain Current  | Pulsed (Note 1)                     | 30          | Α    |
| E <sub>AS</sub>                   | Single Pulsed Avalanche Energy (Note 2)                        |                                     | 57          | mJ   |
| I <sub>AS</sub>                   | Avalanche Current (Note 1)                                     |                                     | 2.3         | Α    |
| E <sub>AR</sub>                   | Repetitive Avalanche Energy (Note 1)                           |                                     | 0.9         | mJ   |
| dv/dt                             | MOSFET dv/dt Peak Diode Recovery dv/dt (Note 3)                |                                     | 100         | V/ns |
|                                   |  |                                     | 20          |      |
| $P_{D}$                           | Power Dissipation  | (T <sub>C</sub> = 25°C)             | 90          | W    |
|                                   |  | Derate Above 25°C                   | 0.72        | W/°C |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Temperature Range                        |                                     | -55 to +150 | °C   |
| TL                                | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 s |                                     | 300         | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse-width limited by maximum junction temperature. 
  2.  $I_{AS}=2.3$  A,  $R_G=25$   $\Omega$ , starting  $T_J=25^{\circ}C$ . 
  3.  $I_{SD}\leq 6$  A, di/dt  $\leq 200$  A/ $\mu$ s,  $V_{DD}\leq 400$  V, starting  $T_J=25^{\circ}C$ .

#### THERMAL CHARACTERISTICS

| Symbol        | Parameter  | Value | Unit |
|---------------|--|-------|------|
| $R_{	hetaJC}$ | Thermal Resistance, Junction to Case, Max.             | 1.39  | °C/W |
| $R_{	hetaJA}$ | Thermal Resistance, Junction to Ambient, Max. (Note 4) | 40    |      |

<sup>4.</sup> Device on 1 in<sup>2</sup> pad 2 oz copper pad on 1.5 x 1.5 in. board of FR-4 material.

## PACKAGE MARKING AND ORDERING INFORMATION

| Part Num | ber  | Top Marking | Package | Reel Size | Tape Width | Shipping <sup>†</sup> |
|----------|------|-------------|---------|-----------|------------|-----------------------|
| FCD260N6 | S5S3 | FCD260N65S3 | D-PAK   | 330 mm    | 16 mm      | 2500 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

| Symbol                         | Parameter  | Test Conditions   | Min | Тур  | Max  | Unit |
|--------------------------------|--|---|-----|------|------|------|
| OFF CHARACT                    | ERISTICS   |   |     | •    | •    |      |
| BV <sub>DSS</sub>              | Drain to Source Breakdown Voltage                        | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA, T <sub>J</sub> = 25°C   | 650 |      |      | V    |
|                                |  | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 150^{\circ}\text{C}$ | 700 |      |      | V    |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Breakdown Voltage Temperature<br>Coefficient             | I <sub>D</sub> = 1 mA, Referenced to 25°C                             |     | 0.66 |      | V/°C |
| I <sub>DSS</sub>               | Zero Gate Voltage Drain Current                          | V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V                        |     |      | 1    | μΑ   |
|                                |  | V <sub>DS</sub> = 520 V, T <sub>C</sub> = 125°C                       |     | 0.77 |      |      |
| I <sub>GSS</sub>               | Gate to Body Leakage Current                             | V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V                        |     |      | ±100 | nA   |
| ON CHARACTE                    | ERISTICS   |   |     |      |      |      |
| V <sub>GS(th)</sub>            | Gate Threshold Voltage                                   | $V_{GS} = V_{DS}, I_D = 0.29 \text{ mA}$                              | 2.5 |      | 4.5  | V    |
| R <sub>DS(on)</sub>            | Static Drain to Source On Resistance                     | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6 A                          |     | 222  | 260  | mΩ   |
| 9FS                            | Forward Transconductance                                 | V <sub>DS</sub> = 20 V, I <sub>D</sub> = 6 A                          |     | 7.4  |      | S    |
| DYNAMIC CHA                    | RACTERISTICS   |   |     |      |      |      |
| C <sub>iss</sub>               | Input Capacitance  | V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, f = 1 MHz             |     | 1010 |      | pF   |
| C <sub>oss</sub>               | Output Capacitance                                       | 7   |     | 25   |      | pF   |
| C <sub>oss(eff.)</sub>         | Effective Output Capacitance                             | V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V                 |     | 248  |      | pF   |
| C <sub>oss(er.)</sub>          | Energy Related Output Capacitance                        | V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V                 |     | 33   |      | pF   |
| Q <sub>g(tot)</sub>            | Total Gate Charge at 10 V                                | $V_{DS} = 400 \text{ V}, I_D = 6 \text{ A}, V_{GS} = 10 \text{ V}$    |     | 24   |      | nC   |
| $Q_{gs}$                       | Gate to Source Gate Charge                               | (Note 5)  |     | 6.1  |      | nC   |
| $Q_{gd}$                       | Gate to Drain "Miller" Charge                            |   |     | 9.7  |      | nC   |
| ESR                            | Equivalent Series Resistance                             | f = 1 MHz   | 8   |      |      | Ω    |
| SWITCHING CH                   | HARACTERISTICS   |   |     |      |      |      |
| t <sub>d(on)</sub>             | Turn-On Delay Time                                       | $V_{DD} = 400 \text{ V}, I_D = 6 \text{ A},$                          |     | 18   |      | ns   |
| t <sub>r</sub>                 | Turn-On Rise Time  | $V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$ (Note 5)                    |     | 18   |      | ns   |
| t <sub>d(off)</sub>            | Turn-Off Delay Time                                      |   |     | 49   |      | ns   |
| t <sub>f</sub>                 | Turn-Off Fall Time                                       |   |     | 12   |      | ns   |
| SOURCE-DRAI                    | N DIODE CHARACTERISTICS                                  |   |     |      |      |      |
| I <sub>S</sub>                 | Maximum Continuous Source to Drain Diode Forward Current |   |     |      | 12   | Α    |
| I <sub>SM</sub>                | Maximum Pulsed Source to Drain Diode Forward Current     |   |     |      | 30   | Α    |
| V <sub>SD</sub>                | Source to Drain Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 6 A                          |     |      | 1.2  | V    |
| t <sub>rr</sub>                | Reverse Recovery Time                                    | V <sub>DD</sub> = 400 V, I <sub>SD</sub> = 6 A,                       |     | 251  |      | ns   |
| Q <sub>rr</sub>                | Reverse Recovery Charge                                  | dl <sub>F</sub> /dt = 100 A/μs  |     | 3.4  |      | μC   |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>5.</sup> Essentially independent of operating temperature typical characteristics.

#### TYPICAL PERFORMANCE CHARACTERISTICS

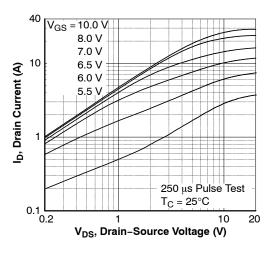


Figure 1. On-Region Characteristics

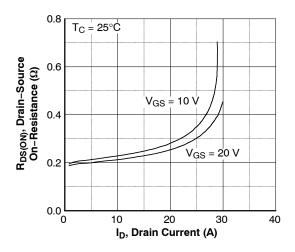


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

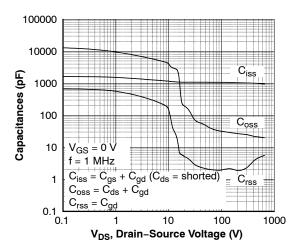


Figure 5. Capacitance Characteristics

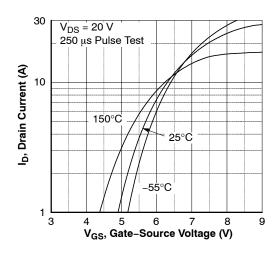


Figure 2. Transfer Characteristics

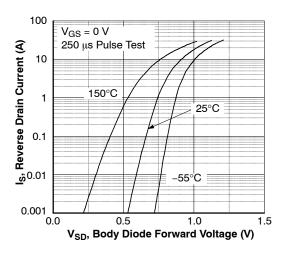


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

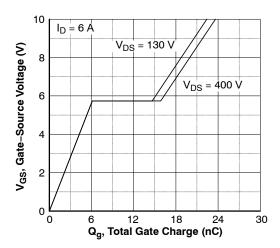


Figure 6. Gate Charge Characteristics

## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

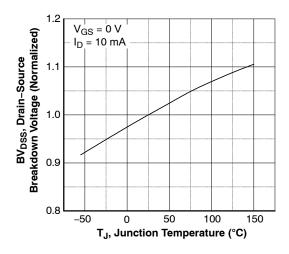


Figure 7. Breakdown Voltage Variation vs. Temperature

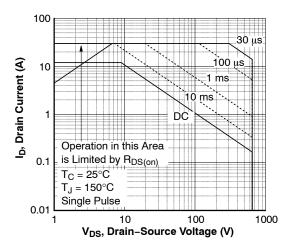


Figure 9. Maximum Safe Operating Area

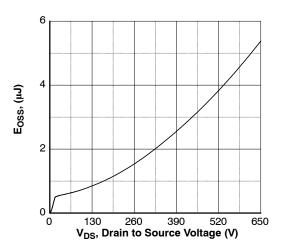


Figure 11.  $E_{\mbox{OSS}}$  vs. Drain to Source Voltage

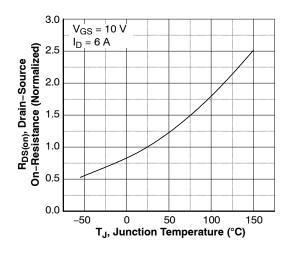


Figure 8. On–Resistance Variation vs. Temperature

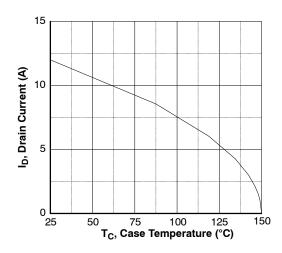


Figure 10. Maximum Drain Current vs. Case Temperature

# TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

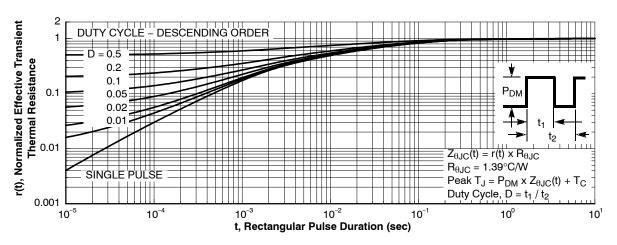


Figure 12. Transient Thermal Response Curve

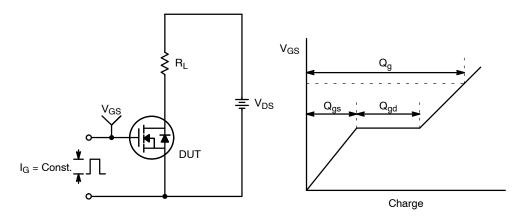


Figure 13. Gate Charge Test Circuit & Waveform

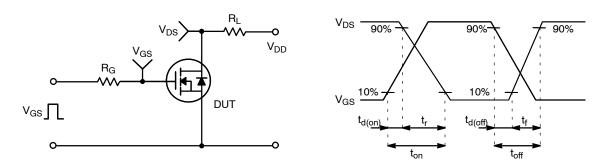


Figure 14. Resistive Switching Test Circuit & Waveforms

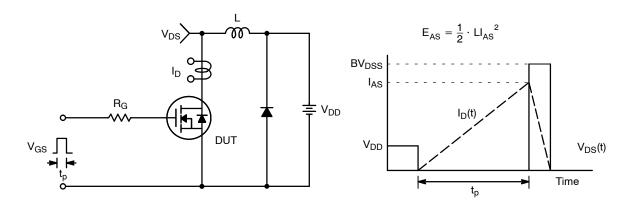


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

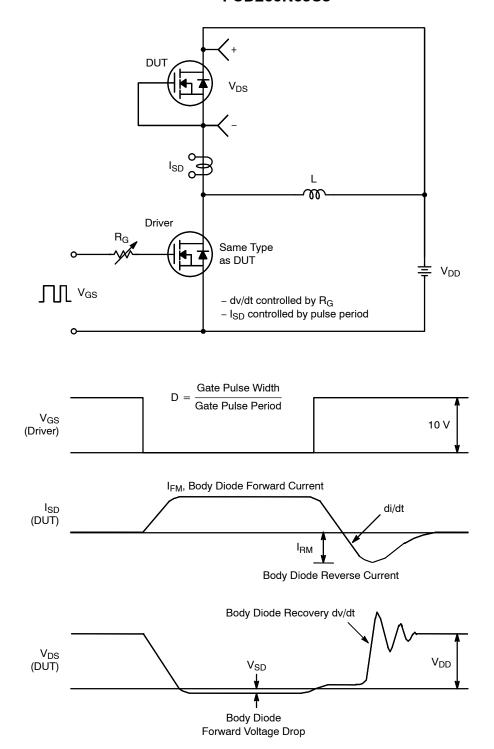


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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 $-\Box$ 

L3

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L4

0.25 MAM C





C

(z)

# **DPAK3 (TO-252 3 LD)**CASE 369AS **ISSUE A**

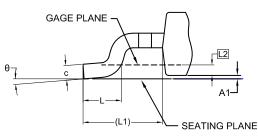
**DATE 28 SEP 2022** 

NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
- CORNERS OR EDGE PROTRUSION.

  FOR DIODE PRODUCTS, L4 IS 0.25 MM MAX.

  F) DIMENSIONS ARE EXCLUSIVE OF BURRS,
- MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



|    | IVIIN.    | NOM. | MAX.  |  |
|----|-----------|------|-------|--|
| Α  | 2.18      | 2.29 | 2.39  |  |
| A1 | 0.00      | -    | 0.127 |  |
| b  | 0.64      | 0.77 | 0.89  |  |
| b2 | 0.76      | 0.95 | 1.14  |  |
| b3 | 5.21      | 5.34 | 5.46  |  |
| С  | 0.45      | 0.53 | 0.61  |  |
| c2 | 0.45      | 0.52 | 0.58  |  |
| D  | 5.97      | 6.10 | 6.22  |  |
| D1 | 5.21      | _    | _     |  |
| Е  | 6.35      | 6.54 | 6.73  |  |
| E1 | 4.32      | _    | _     |  |
| е  | 2.286 BSC |      |       |  |
| e1 | 4.572 BSC |      |       |  |
| Н  | 9.40      | 9.91 | 10.41 |  |
| 1  | 1.40      | 1 59 | 1 78  |  |

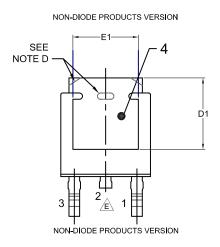
2 90 RFF

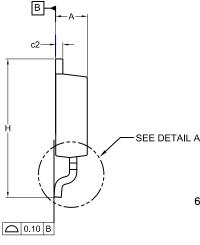
0.51 BSC

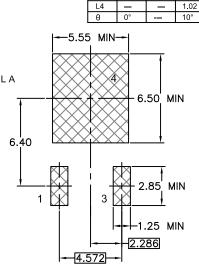
1.08

MILLIMETERS

**DETAIL A** (ROTATED -90°) SCALE: 12X







1.1

12

L3

## **GENERIC MARKING DIAGRAM\***

XXXXXX XXXXXX **AYWWZZ** 

XXXX = Specific Device Code

= Assembly Location Α

WW = Work Week

= Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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|------------------|---------------------|--|-------------|--|
| DESCRIPTION:     | DPAK3 (TO-252 3 LD) |  | PAGE 1 OF 1 |  |

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